TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

SSM6N09FU

High Speed Switching Applications

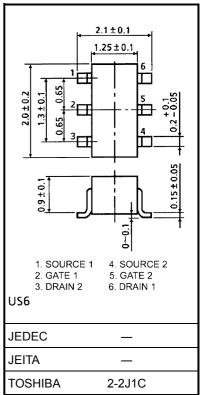
- Small package
- Low Drain-Source ON resistance.
 - $R_{on} = 0.7 \Omega (max) (@V_{GS} = 10 V)$
 - : Ron = 1.2 Ω (max) (@V_{\rm GS} = 4 V)

Note1: Total rating, mounted on FR4 board

Maximum Ratings (Ta = 25°C) (Q1, Q2 Common)

Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		V _{DS}	30	V	
Gate-Source voltage		V _{GSS}	±20	V	
Drain current	DC	۱ _D	400	mA	
	Pulse	I _{DP}	800		
Drain power dissipation (Ta = 25° C)		P _D (Note1)	300	mW	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

(25.4 mm \times 25.4 mm \times 1.6 t, Cu Pad: 0.32 mm $^2 \times$ 6) Figure 1.



Weight: 6.8 mg (typ.)

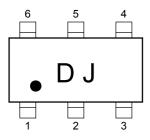
Handling Precaution

When handling individual devices (which are not yet mounting on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.



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Marking



Equivalent Circuit (top view)

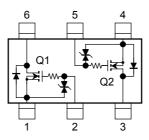


Figure 1: 25.4 mm × 25.4 mm × 1.6 t,

Cu Pad: $0.32 \text{ mm}^2 \times 6$

Electrical Characteristics (Ta = 25°C) (Q1, Q2 common)

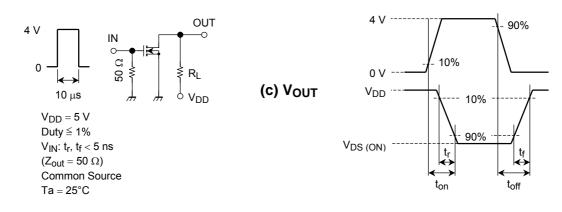
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage current		I _{GSS}	$V_{GS}=\pm 16~V,~V_{DS}=0$			±1	μA	
Drain-Source breakdown voltage		V (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	30		_	V	
Drain cut-off current		I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0$			1	μA	
Gate threshold voltage		V _{th}	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	1.1		1.8	V	
Forward transfer admittance		Y _{fs}	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 200 \text{ mA} \qquad (\text{Note2})$	270		_	mS	
Drain-Source ON resistance		R _{DS (ON)}	$I_D = 200 \text{ mA}, V_{GS} = 10 \text{ V}$ (Note2)		0.53	0.7	Ω	
			$I_D = 200 \text{ mA}, V_{GS} = 4 \text{ V} \qquad (\text{Note2})$		0.8	1.2		
			$I_D = 200 \text{ mA}, V_{GS} = 3.3 \text{ V}$ (Note2)	_	1.0	1.7		
Input capacitance		C _{iss}	$V_{DS} = 5 V, V_{GS} = 0, f = 1 MHz$	_	20		pF	
Reverse transfer capacitance		C _{rss}	$V_{DS} = 5 V, V_{GS} = 0, f = 1 MHz$	_	7		pF	
Output capacitance		C _{oss}	$V_{DS} = 5 V, V_{GS} = 0, f = 1 MHz$		16		pF	
Switching time	Turn-on time	t _{on}	$V_{DD} = 5 \text{ V}, \text{ I}_{D} = 200 \text{ mA},$		72			
	Turn-off time	t _{off}	V _{GS} = 0~4 V	_	68		ns	

Note2: Pulse test

Switching Time Test Circuit (Q1, Q2 Common)

(a) Test circuit

(b) V_{IN}

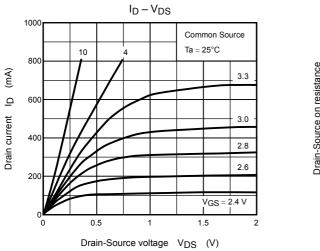


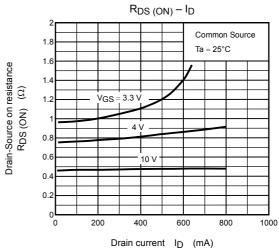
Precaution

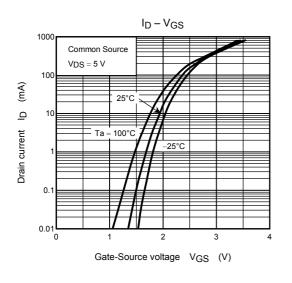
 V_{th} can be expressed as voltage between gate and source when low operating current value is $I_D = 100 \ \mu A$ for this product. For normal switching operation, V_{GS} (on) requires higher voltage than V_{th} and V_{GS} (off) requires lower voltage than V_{th} . (Relationship can be established as follows: V_{GS} (off) $< V_{th} < V_{GS}$ (on))

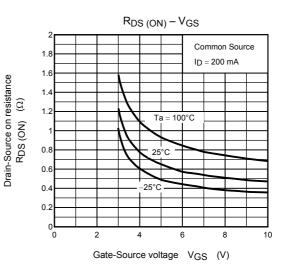
Please take this into consideration for using the device. VGS recommended voltage of 4 V or higher to turn on this product.

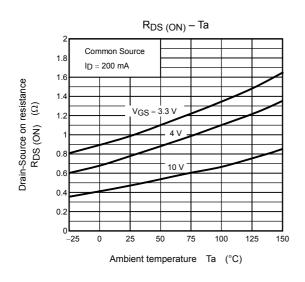
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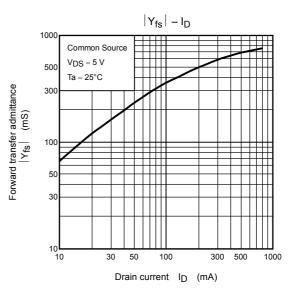




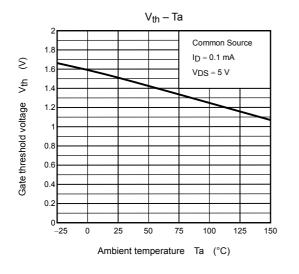


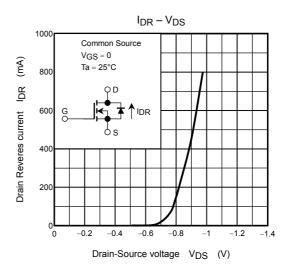


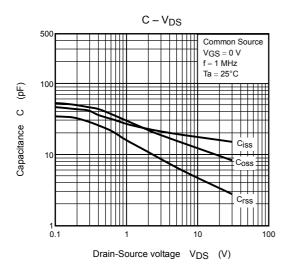


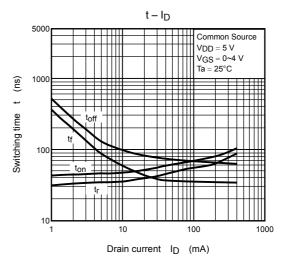


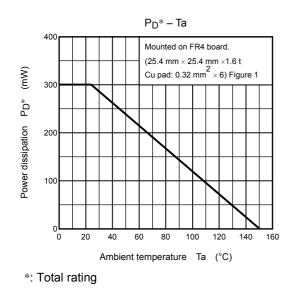
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